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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/034,656	12/26/2001	Jong Sik Paek	AMKOR-015A	1810
7663	7590	12/17/2003	EXAMINER	
STETINA BRUNDA GARRED & BRUCKER			VU, HUNG K	
75 ENTERPRISE, SUITE 250			ART UNIT	
ALISO VIEJO, CA 92656			PAPER NUMBER	
			2811	

DATE MAILED: 12/17/2003

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

10/034,656

Applicant(s)

PAEK, JONG SIK

Examiner

Hung K. Vu

Art Unit

2811

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE ____ MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☐ Responsive to communication(s) filed on ____.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☐ Claim(s) ____ is/are pending in the application.
- 4a) Of the above claim(s) ____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) ____ is/are allowed.
- 6) ☐ Claim(s) ____ is/are rejected.
- 7) ☐ Claim(s) ____ is/are objected to.
- 8) ☐ Claim(s) ____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on ____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. §§ 119 and 120

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. ____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
* See the attached detailed Office action for a list of the certified copies not received.
- 13) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application) since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78.
a) ☐ The translation of the foreign language provisional application has been received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121 since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78.

Attachment(s)

- 1) ☐ Notice of References Cited (PTO-892) 4) ☐ Interview Summary (PTO-413) Paper No(s). ____ .
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948) 5) ☐ Notice of Informal Patent Application (PTO-152)
- 3) ☐ Information Disclosure Statement(s) (PTO-1449) Paper No(s) ____ . 6) ☐ Other: .

DETAILED ACTION

Claim Objections

1. Claim 16 is objected to because of the following informalities: In claim 16, line 2, “have” should be changed to “has” for clarity. Appropriate correction is required.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-3 and 8-9 are rejected under 35 U.S.C. 102(b) as being anticipated by Shin et al. (PN 5,866,939, of record).

Shin et al. discloses, as shown in Figures 1A, 5A-5B, 10B, 11C and 19-21, a semiconductor package comprising:

a plurality of leads (2), each of the leads defining first and second surfaces and including:

a pad portion (4);

at least one connecting bar portion (2a,2b) integrally connected to and extending from the pad portion;

at least some of the leads (2) each having a bump land (upper portion of the pad 4) formed on the second surface upon the pad portion (4) thereof and at least some of the leads

(2) each having a bump land (upper portion of the pad 4) formed on the second surface upon the connecting bar portion (2a,2b) thereof [Figures 10B, 11C and 19-21];

a semiconductor (20) defining opposed first and second surfaces and including a plurality of input/output pads (not shown) disposed on the first surface thereof [Col. 15, lines 20-25, Col. 16, lines 38-43];

a plurality of conductive bumps (31) electrically connecting the input/output pads to respective ones of the bump lands;

an encapsulant portion (40) covering the semiconductor chip, the conductive bumps, and the second surfaces of the leads such that at least portions of the first surfaces of the leads are exposed within the encapsulant portion.

With regard to claim 2, Shin et al. discloses the first surface of the semiconductor chip is disposed at a prescribed separation distance from the second surfaces of the leads [Figures 10B, 11C and 19-21].

With regard to claim 3, Shin et al. discloses the first and second surfaces of each of the leads are generally planar and extend in opposed relation to each other;

each of the leads further includes a third surface formed between the first and second surfaces thereof;

the third surface of each of the leads is covered by the encapsulant portion;

the first surface of each of the leads is exposed within the encapsulant portion to serve as an input/output terminal [Figures 10B, 11C and 19-21].

With regard to claim 8, Shin et al. discloses the pad portions (4) of the leads are segregated into an outer set and an inner set;

the pad portions (4) of the inner set each includes a bump land formed thereon;

at least one connecting bar portion (2a,2b) extending from each of the pad portions of the outer set includes a bump land formed thereon [Figures 1B, 10B, 11C and 19-21].

With regard to claim 9, Shin et al. discloses the first and second surfaces of each of the leads (2) are generally planar and extend in opposed relation to each other;

each of the leads further includes a third surface formed between the first and second surface thereof in opposed relation to that segment of the second surface which extends along the connecting bar portion (2a,2b);

the third surface of each of the leads is covered by the encapsulant portion (40);

the first surface of each of the leads extending along the pad portion thereof is exposed within the encapsulant portion to serve as an input/output terminal [Figures 1B, 10B, 11C and 19-21].

Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 5-6 and 10-16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Shin et al. (PN 5,866,939, of record) in view of Baba et al. (PN 5,969,426, of record).

With regard to claims 5 and 10, Shin et al. discloses the invention as claimed including the semiconductor package as cited in the rejection above. Shin et al. does not disclose each of the leads includes a protective layer formed on the second surface thereof other than for the prescribed region including the bump land. However, Baba et al. discloses each of the leads (7) includes a protective layer (21) formed on the second surface thereof other than for the prescribed region including the bump land. Note Figure 13 of Baba et al.. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to form the leads of Shin et al. each includes a protective layer formed on the second surface thereof other than for the prescribed region including the bump land, such as taught by Baba et al., in order to prevent the diffusion of the bumps into the lead pattern and to control the configuration of the bumps.

With regard to claim 11, Shin et al. discloses the first surface of the semiconductor chip is disposed at a prescribed separation distance from the second surfaces of the leads [Figures 10B, 11C and 19-21].

With regard to claim 12, Shin et al. discloses the first and second surfaces of each of the leads are generally planar and extend in opposed relation to each other;

each of the leads further includes a third surface formed between the first and second surfaces thereof;

Art Unit: 2811

the third surface of each of the leads is covered by the encapsulant portion;

the first surface of each of the leads is exposed within the encapsulant portion to serve as an input/output terminal [Figures 10B, 11C and 19-21].

With regard to claims 6 and 13, Shin et al. and Baba et al. disclose the protective layer is selected from the group consisting of polyimide [Col. 10, lines 9-11].

With regard to claim 14, Shin et al. and Baba et al. disclose the pad portions (4) of the leads are segregated into an outer set and an inner set;

the pad portions (4) of the inner set each includes a bump land formed thereon;

at least one connecting bar portion (2a,2b) extending from each of the pad portions of the outer set includes a bump land formed thereon [Figures 1B, 10B, 11C and 19-21].

With regard to claim 15, Shin et al. and Baba et al. disclose the first and second surfaces of each of the leads (2) are generally planar and extend in opposed relation to each other;

each of the leads further includes a third surface formed between the first and second surface thereof in opposed relation to that segment of the second surface which extends along the connecting bar portion (2a,2b);

the third surface of each of the leads is covered by the encapsulant portion (40);

the first surface of each of the leads extending along the pad portion thereof is exposed within the encapsulant portion to serve as an input/output terminal [Figures 1B, 10B, 11C and 19-21].

With regard to claim 16, Shin et al. and Baba et al. disclose the pad portions and the bump lands each has a circular footprint [Figures 5A-6B, note that since the solder bump is round, the bump land should have a circular footprint upon contacting the solder bump].

Response to Arguments

4. Applicant's arguments filed 09/15/03 have been fully considered but they are not persuasive.

It is argued, at pages 7-8 of the Remarks, that Shin et al. does not disclose a semiconductor package having some leads which each have a bump land formed on a pad portion thereof and some leads which each have a bump land formed on a connecting bar portion thereof, as recited in claim 1. This argument is not convincing because Shin et al. discloses, as shown in Figures 10B, 11C and 19-21, at least some of the leads (2) each having a bump land (upper portion of the pad 4) formed on the second surface upon the pad portion (4) thereof and at least some of the leads (2) each having a bump land (upper portion of the pad 4) formed on the second surface upon the connecting bar portion (2a,2b) thereof.

Since Applicant's Claim 1 does not overcome the rejection of Shin et al., Claims 2-3, 5-6, 8-9 and 10-16 still do not distinguish over the rejection of Shin et al. and/or in view of Baba et al. references.

Conclusion

5. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hung K. Vu whose telephone number is (703) 308-4079. The examiner can normally be reached on Mon-Thurs 6:00-3:30, alternate Friday 7:00-3:30, Eastern Time.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie C. Lee can be reached on (703) 308-1690. The Central Fax Number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

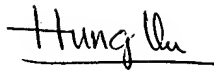
Application/Control Number: 10/034,656

Page 9

Art Unit: 2811

Vu

December 11, 2003

A handwritten signature in dark ink, appearing to read "Hung Vu", written over a horizontal line.

Hung Vu

Patent Examiner